

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/447,080	PARK ET AL.	
Examiner	Art Unit	
Jennifer T. Nguyen	2674	

SEARCHED				
Class	Subclass	. Date	Examiner	
345	173_	7/18/05	JN	
	178			
178	18.01-		:	
	18.09			
	20.01			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East Search	7/15/05	W		